

## Product Summary

$V_{DS}$	1200 V
$I_D$ ( $T_c=25^\circ\text{C}$ )	86 A
$R_{DS(on),\text{typ}}$	35 m $\Omega$ @ $V_{GS}=18\text{V}$

## Features

- Low On-Resistance with High Blocking Voltage
- Low Capacitance
- Avalanche Ruggedness
- Halogen Free, RoHS Compliant

## Benefits

- High Frequency Operation
- Enabling Higher Switching Frequency
- Increased Power Density
- Reduction of Heat Sink Requirements

## Applications

- Switch Mode Power Supplies (SMPS)
- Power Inverter & Solar Inverter
- Motor Drivers & EV Charging Station
- DC/DC Converter

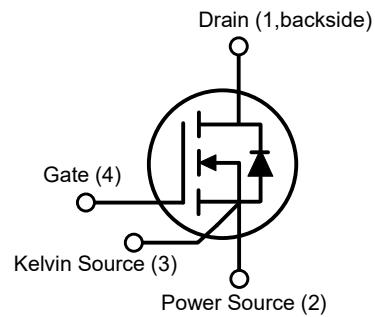
## Package Pin Definitions

- Pin1 and backside - Drain
- Pin2 - Power Source
- Pin3 - Kelvin Source
- Pin4 - Gate

## Package Parameters

Part Number	Marking	Package
B2M035120YP	B2M035120YP	TO-247-4PLUS

## Package: TO-247-4PLUS



## Maximum Ratings

Symbol	Parameter	Test conditions	Value	Unit
$V_{DSmax}$	Drain-Source Voltage	$V_{GS}=0V, I_D=100\mu A$	1200	V
$V_{GSmax}^{1)}$	Gate-Source Voltage		-8/22	V
$V_{GSop}$	Recommend Gate-Source Voltage		-4/18	V
$I_D$	Continuous Drain Current	$V_{GS}=18V, T_c=25^\circ C$	86	A
		$V_{GS}=18V, T_c=100^\circ C$	60	A
$I_{D,pulse}$	Pulsed Drain Current	Pulse with $t_p$ limited by $T_{jmax}$	190	A
$P_{tot}$	Power Dissipation	$T_c=25^\circ C, T_j=175^\circ C$	375	W
$T_j$	Operating Junction Temperature		-55~175	°C
$T_{stg}$	Storage Temperature		-55~175	°C

1) Note: When using MOSFET Body Diode  $V_{GSmax}=-4/22V$

## Electrical Characteristics (Defined at $T_j=25^\circ C$ unless otherwise specified)

### Static Characteristics

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=100\mu A$	1200			V
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}, I_D=10mA$	2.3	2.8	3.5	V
		$V_{GS}=V_{DS}, I_D=10mA, T_j=175^\circ C$		1.9		
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=18V, V_{DS}=0V$			100	nA
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=1200V, V_{GS}=0V$		1	50	$\mu A$
		$V_{DS}=1200V, V_{GS}=0V, T_j=175^\circ C$		10	200	
$R_{DS(on)}$	Drain-Source On-State Resistance	$V_{GS}=18V, I_D=40A$		35	50	$m\Omega$
		$V_{GS}=18V, I_D=40A, T_j=175^\circ C$		50		
$g_{fs}$	Transconductance	$V_{DS}=10V, I_D=40A$		18		S

**Thermal Characteristics**

Symbol	Parameter	Value			Unit
		Min.	Typ.	Max.	
$R_{th(jc)}$	Thermal Resistance from Junction to Case		0.40		K/W

**AC Characteristics**

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$C_{iss}$	Input Capacitance	$V_{GS}=0V, V_{DS}=800V$ $f=100KHz, V_{AC}=25mV$		2700		pF
$C_{oss}$	Output Capacitance			150		pF
$C_{rss}$	Reverse Transfer Capacitance			7		pF
$R_{G(int)}$	Internal Gate Resistance	$f=1MHz, V_{AC}=25mV$		1.2		$\Omega$

**Gate Charge Characteristics**

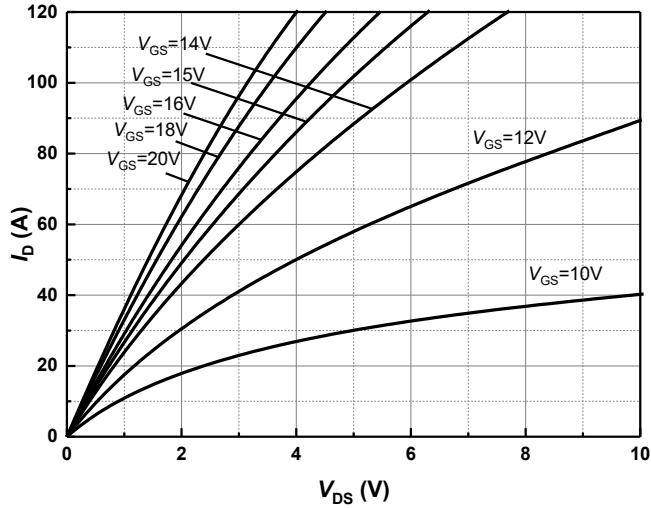
Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$Q_{GS}$	Gate to Source Charge	$V_{DS} = 800V$ $I_D = 40A$ $V_{GS} = -4/+18V$		40		nC
$Q_{GD}$	Gate to Drain Charge			57		nC
$Q_G$	Total Gate Charge			115		nC

### Switching Characteristics

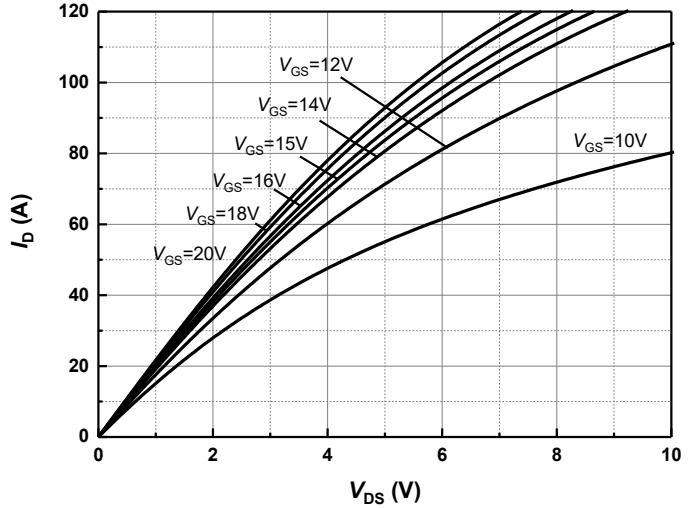
Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$t_{d(on)}$	Turn-On Delay Time	$V_{DC}=800V, V_{GS}=-4/18V$ $I_D=40A, R_{G(ext)}=8.2\Omega$ $L_o=70nH, T_j=25^\circ C$ diode: body diode at $V_{GS}=-4V$ Inductive Load Eon includes diode reverse recovery		9		ns
$t_r$	Rise Time			40		ns
$t_{d(off)}$	Turn-Off Delay Time			35		ns
$t_f$	Fall Time			16		ns
$E_{on}$	Turn-On Energy			770		uJ
$E_{off}$	Turn-Off Energy			370		uJ
$t_{d(on)}$	Turn-On Delay Time	$V_{DC}=800V, V_{GS}=-4/18V$ $I_D=40A, R_{G(ext)}=8.2\Omega$ $L_o=70nH, T_j=175^\circ C$ diode: body diode at $V_{GS}=-4V$ Inductive Load Eon includes diode reverse recovery		9		ns
$t_r$	Rise Time			40		ns
$t_{d(off)}$	Turn-Off Delay Time			42		ns
$t_f$	Fall Time			16		ns
$E_{on}$	Turn-On Energy			870		uJ
$E_{off}$	Turn-Off Energy			380		uJ

### Reverse Diode Characteristics

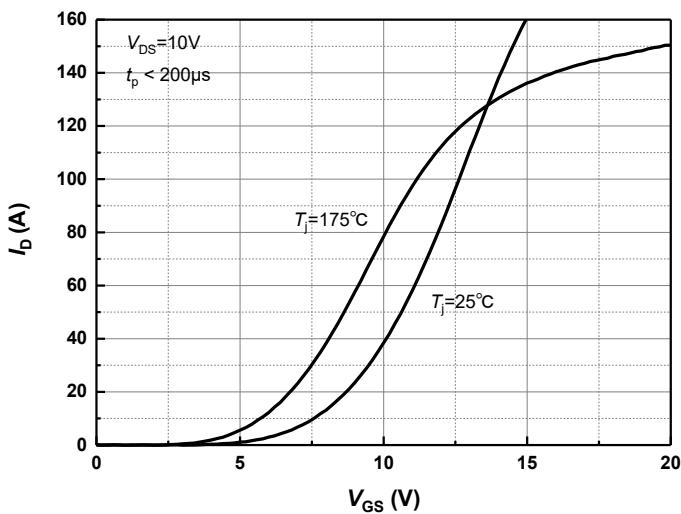
Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$V_{SD}$	Diode Forward Voltage	$V_{GS}=-4V, I_{SD}=20A, T_j=25^\circ C$		4.4		V
		$V_{GS}=-4V, I_{SD}=20A, T_j=175^\circ C$		3.7		
$I_{SD}$	Continuous Diode Forward Current	$V_{GS}=-4V, T_c=25^\circ C$			68	A
$I_{SD,pulse}$	Pulse Diode Current	$V_{GS}=-4V$ , pulse width $t_p$ limited by $T_{jmax}$		170		A
$t_{rr}$	Reverse Recovery Time	$V_{DC}=800V, I_{SD}=40A$ $-di_F/dt=2200A/\mu s$ $T_j=25^\circ C$		20		ns
$Q_{rr}$	Reverse Recovery Charge			220		nC
$I_{rrm}$	Peak Reverse Recovery Current			20		A
$t_{rr}$	Reverse Recovery Time	$V_{DC}=800V, I_{SD}=40A$ $-di_F/dt=2200A/\mu s$ $T_j=175^\circ C$		28		ns
$Q_{rr}$	Reverse Recovery Charge			865		nC
$I_{rrm}$	Peak Reverse Recovery Current			52		A

**Typical Performance**


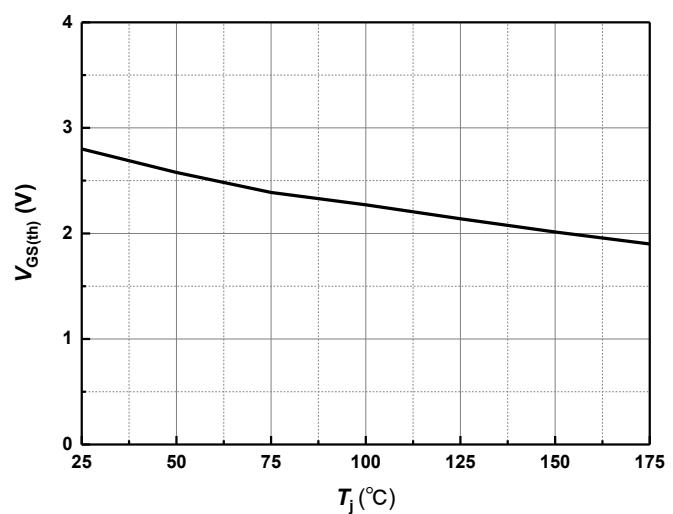
**Figure 1** Typical Forward Output Characteristics at  $T_j=25^\circ\text{C}$



**Figure 2** Typical Forward Output Characteristics at  $T_j=175^\circ\text{C}$

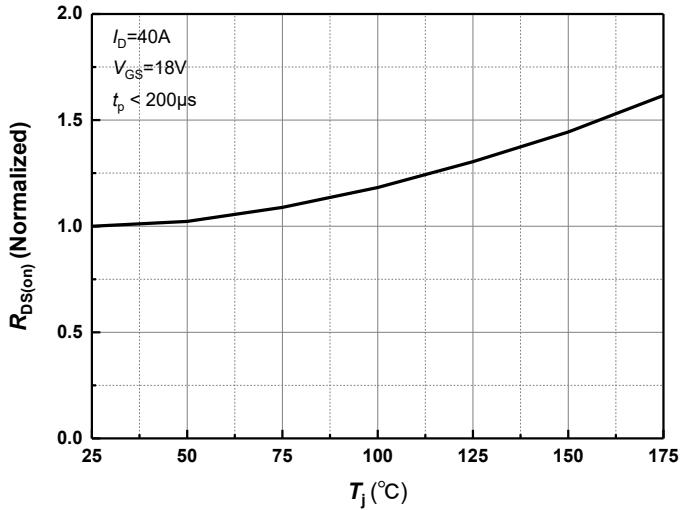


**Figure 3** Transfer Characteristics for Various Temperature

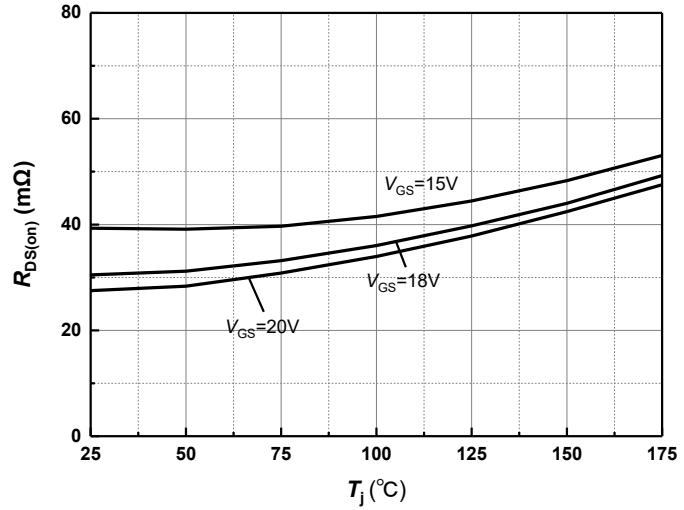


**Figure 4** Threshold Voltage for Various Temperature

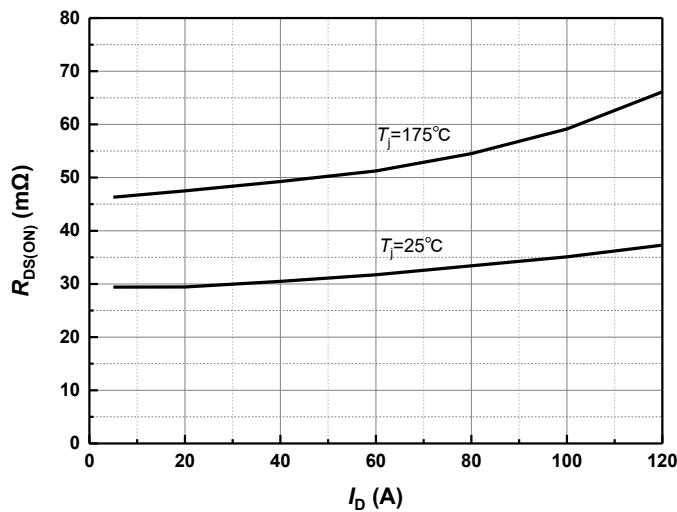
### Typical Performance



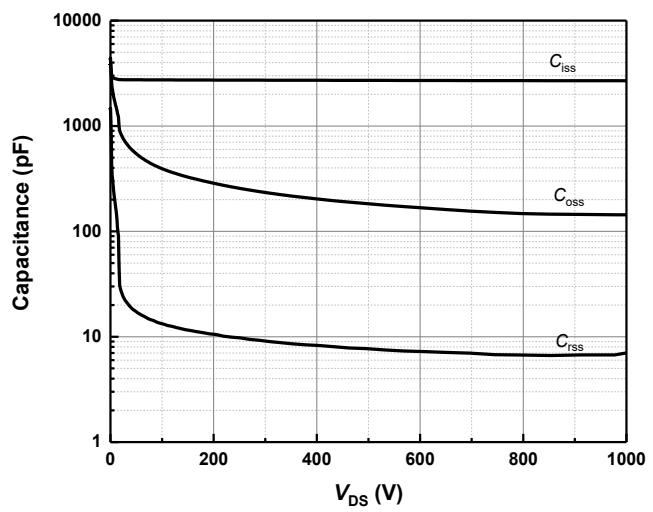
**Figure 5** Normalized On-Resistance for Various Temperature



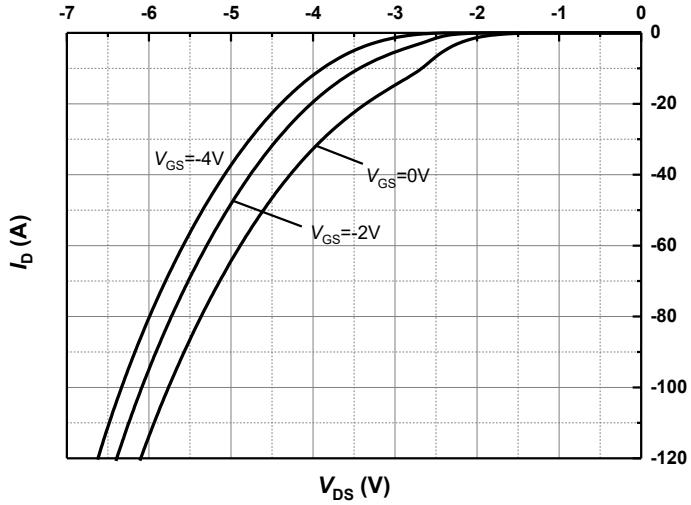
**Figure 6** On-Resistance vs. Temperature for Various Gate-Source Voltage



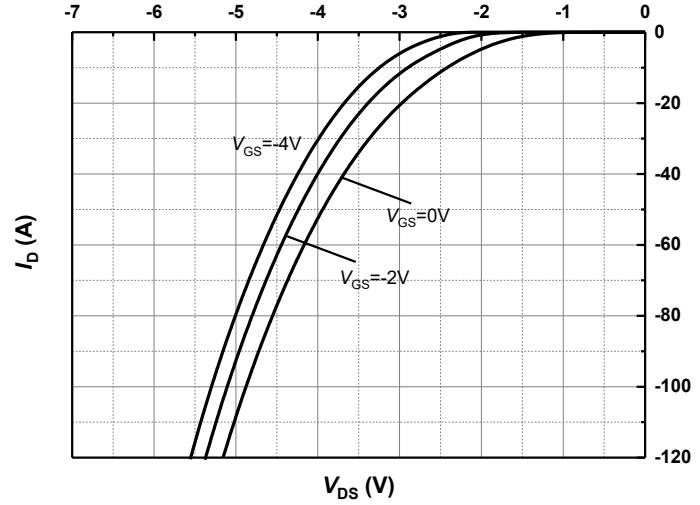
**Figure 7** On-Resistance vs. Drain Current for Various Temperature



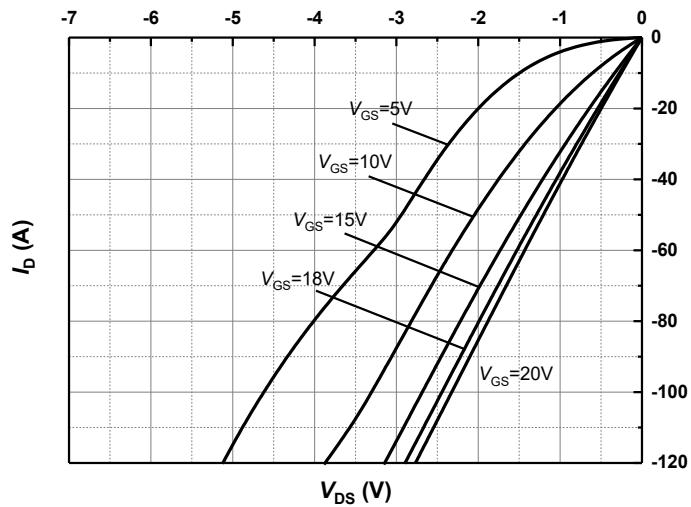
**Figure 8** Capacitance vs. Drain-Source Voltage (0 - 1000V)

**Typical Performance**


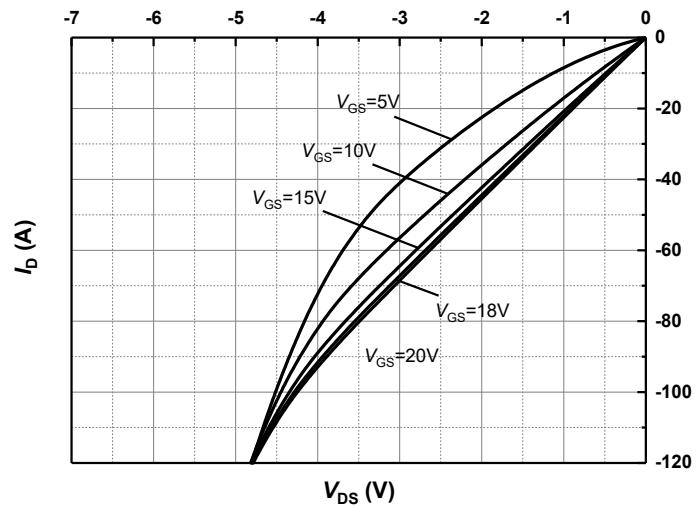
**Figure 9**    **Body Diode Characteristics at  $T_j = 25^\circ\text{C}$**



**Figure 10**    **Body Diode Characteristics at  $T_j = 175^\circ\text{C}$**



**Figure 11**    **3rd Quadrant Characteristics at  $T_j = 25^\circ\text{C}$**



**Figure 12**    **3rd Quadrant Characteristics at  $T_j = 175^\circ\text{C}$**

### Typical Performance

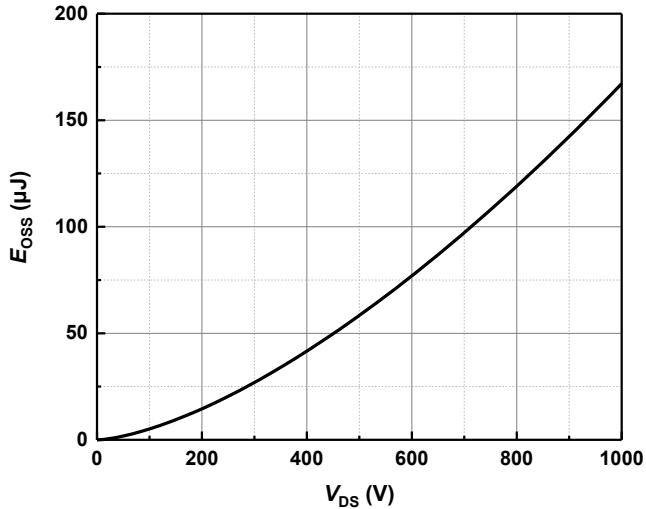


Figure 13 Output Capacitor stored Energy

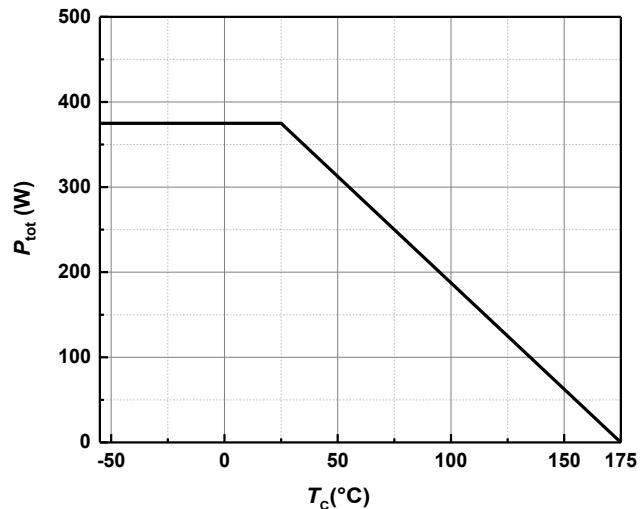


Figure 14 Maximum Power Dissipation Derating vs. Case Temperature

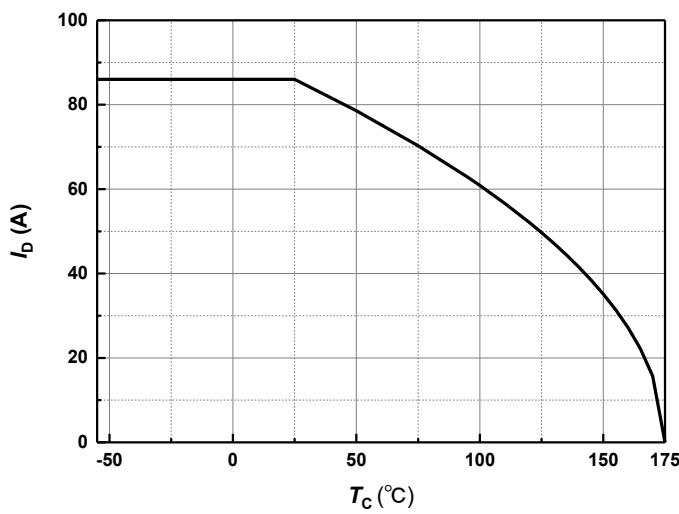


Figure 15 Continuous Drain Current Derating vs. Case Temperature

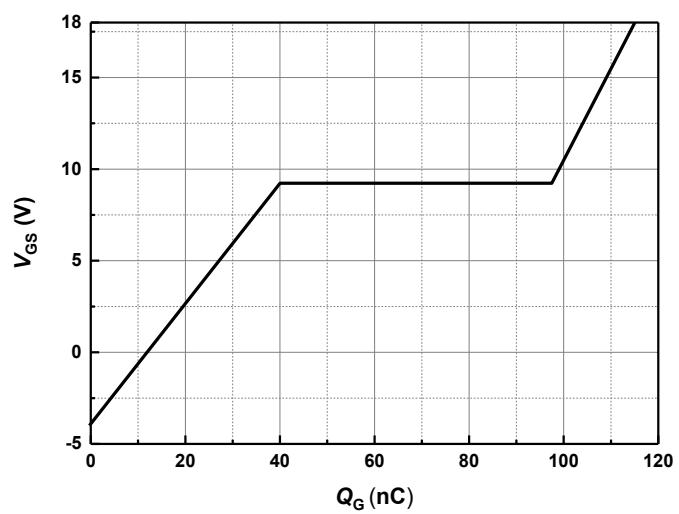
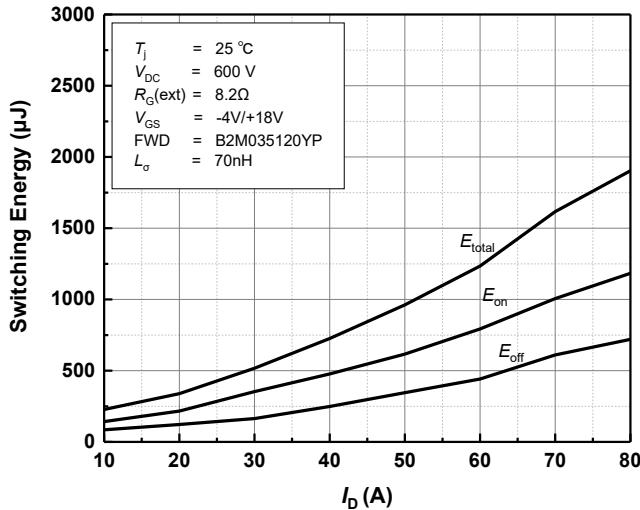
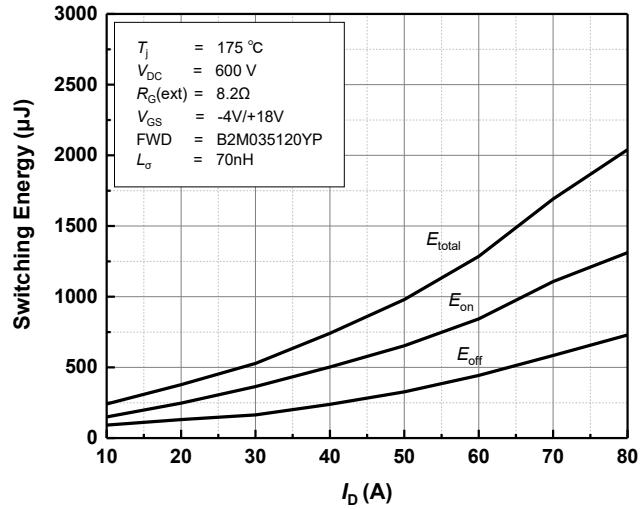


Figure 16 Gate Charge Characteristics

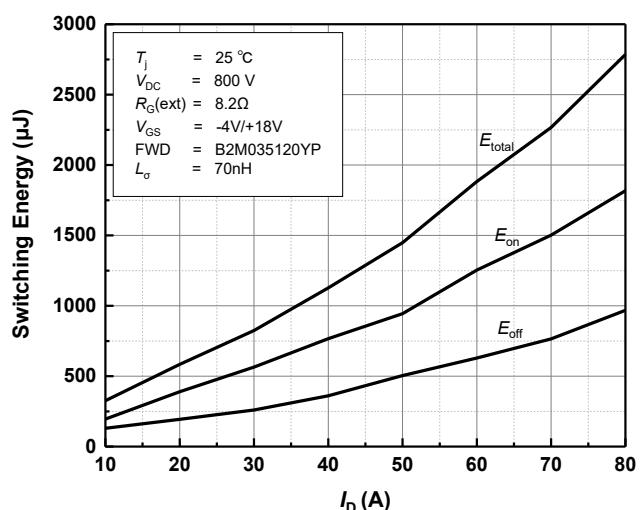
### Typical Performance



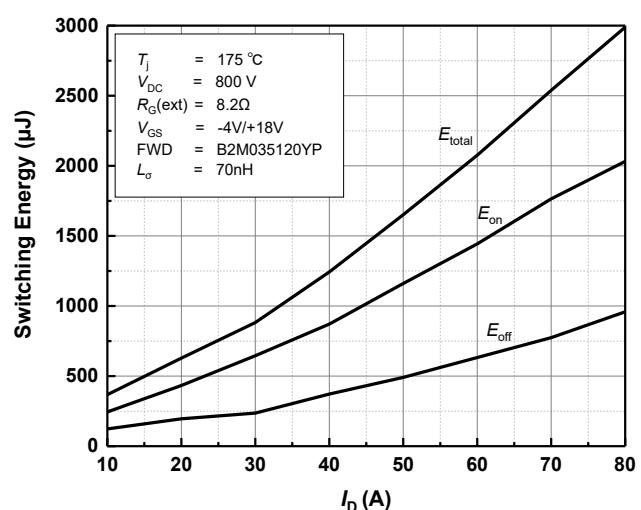
**Figure 17** Clamped Inductive Switching Energy vs. Drain Current ( $V_{DC} = 600\text{V}$ ) at  $T_j = 25^\circ\text{C}$



**Figure 18** Clamped Inductive Switching Energy vs. Drain Current ( $V_{DC} = 600\text{V}$ ) at  $T_j = 175^\circ\text{C}$

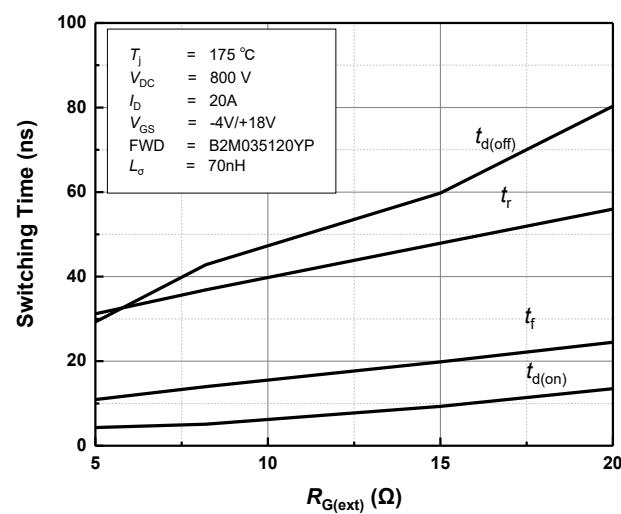
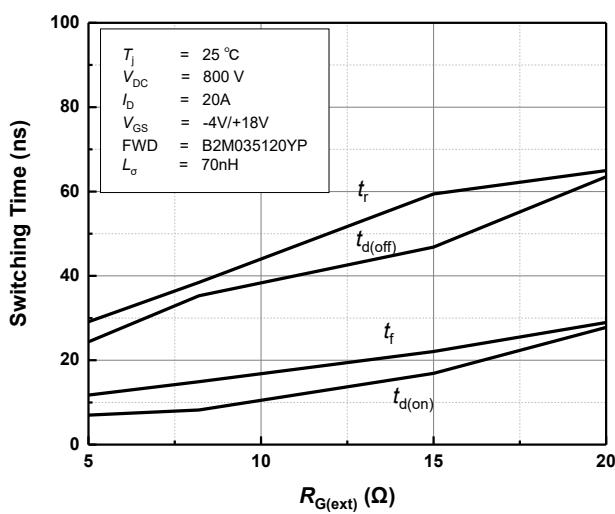
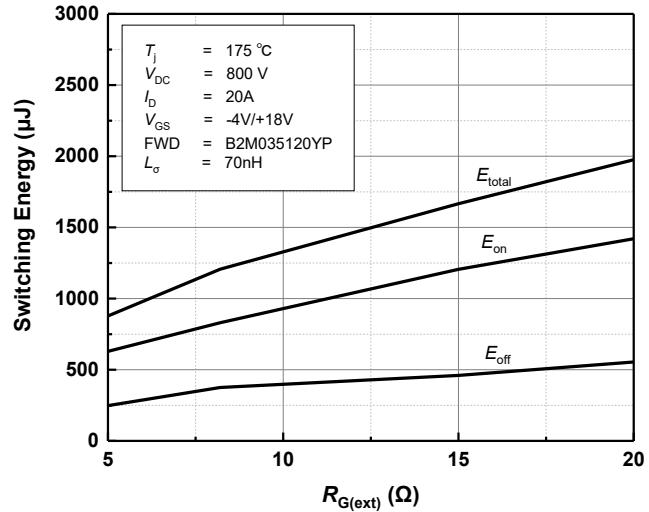
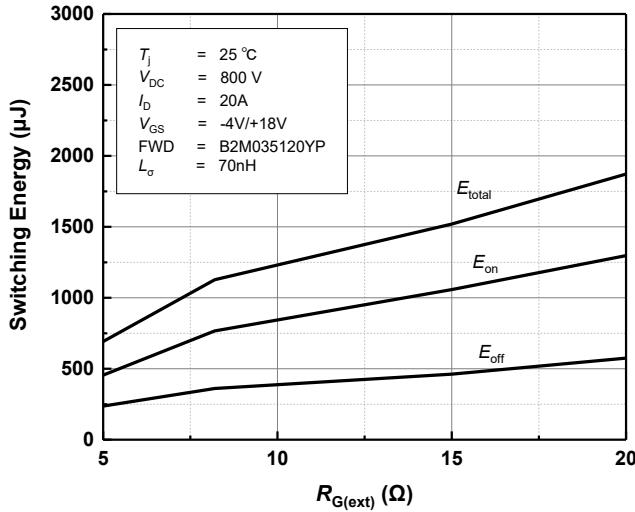


**Figure 19** Clamped Inductive Switching Energy vs. Drain Current ( $V_{DC} = 800\text{V}$ ) at  $T_j = 25^\circ\text{C}$

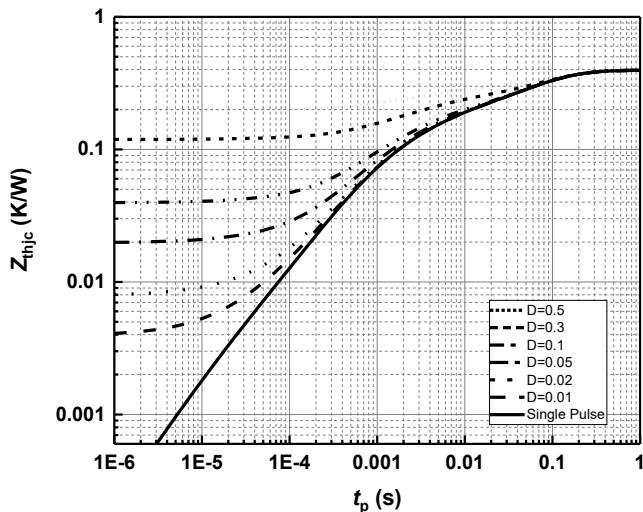


**Figure 20** Clamped Inductive Switching Energy vs. Drain Current ( $V_{DC} = 800\text{V}$ ) at  $T_j = 175^\circ\text{C}$

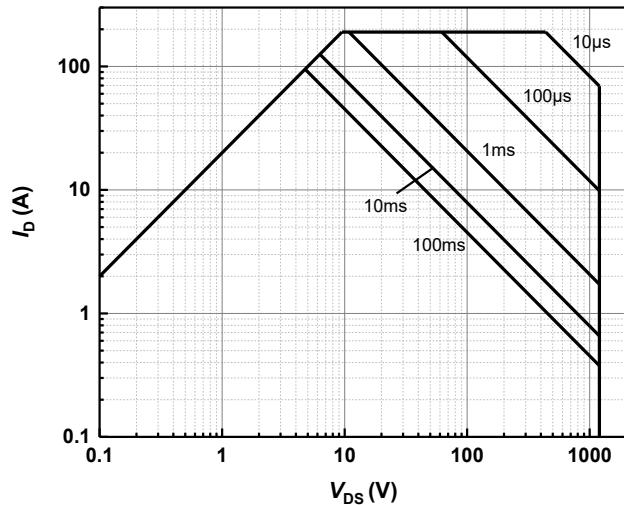
### Typical Performance



### Typical Performance

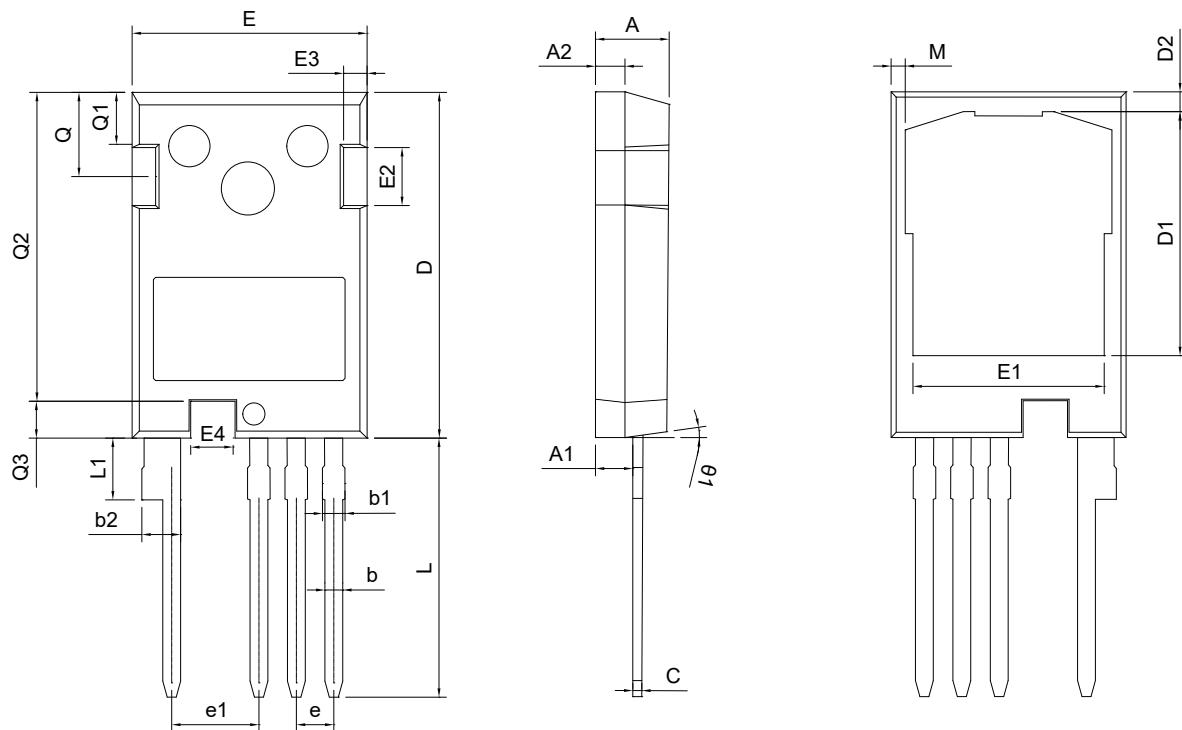


**Figure 25** Transient Thermal Impedance (Junction - Case)



**Figure 26** Forward Biased Safe Operating Area

### Package Dimensions



SYMBOL	mm		
	MIN	NOM	MAX
A	4.83	5.02	5.21
A1	2.29	2.42	2.54
A2	1.91	2.00	2.16
b	1.07	1.20	1.33
b1	1.15	1.30	1.45
b2	2.39	2.67	2.94
c	0.50	0.60	0.75
D	23.30	23.45	23.60
D1	16.35	16.65	16.95
D2	0.95	1.19	1.25
E	15.75	15.94	16.13
E1	13.05	13.25	13.45
E2	4.00	4.40	4.80
E3	1.00	1.45	1.90
E4	2.40	2.80	3.20
e	2.54BSC		
e1	5.08BSC		
L	17.31	17.57	17.82
L1	-	-	4.37
M	0.40	0.60	0.80
Q	5.49	5.79	6.00
Q1	2.80	3.10	3.40
Q2	19.95	21.25	21.55
Q3	2.35	2.50	2.65
θ1	6°	10°	13°

## Revision History

Document Version	Date of Release	Description of Changes
Rev. 0.0	2023-06-09	Draft datasheet created.

**BASiC Semiconductor Ltd.**  
**Shenzhen, China**  
**© 2023 BASiC Semiconductor Ltd.**  
**All Rights Reserved.**

## Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest BASiC Semiconductor Office

## Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, BASiC semiconductor Ltd. hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.